


<b>Search Notes</b>  	<b>Application/Control No.</b>  10765281	<b>Applicant(s)/Patent Under Reexamination</b>  IWASAKI ET AL.
	<b>Examiner</b>  Leung, Quyen P	<b>Art Unit</b>  2874

SEARCHED			
Class	Subclass	Date	Examiner
385	129-132, 146	22 Jan 2007	QPL

SEARCH NOTES		
Search Notes	Date	Examiner
see search strategy	22 Jan 2007	QPL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	text search in US PGPubs, see search strategy	22 Jan 2007	QPL